TOSHIBA Field Effect Transistor Silicon NPN Epitaxial Type (PCT process) (Darlington)

2SD1784

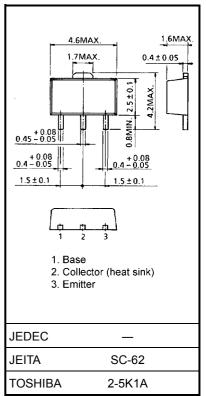
Micro Motor Drive, Hammer Drive Applications Switching Applications Power Amplifier Applications

- High DC current gain: $h_{FE} = 4000 \text{ (min)} (V_{CE} = 2 \text{ V}, I_C = 150 \text{ mA})$
- Low saturation voltage: V_{CE} (sat) = 1.5 V (max) (I_C = 1 A, I_B = 1 mA)

Maximum Ratings (Ta = 25°C)

Characteristics	Symbol	Rating	Unit	
Collector-base voltage	V _{CBO}	30	V	
Collector-emitter voltage	V _{CEO}	30	V	
Emitter-base voltage	V _{EBO}	10	V	
Collector current	Ι _C	1.5	А	
Base current	Ι _Β	50	mA	
Collector power dissipation	P _C (Note)	1000	mW	
Junction temperature	Tj	150	°C	
Storage temperature range	T _{stg}	−55 to 150	°C	

Note: 2SD1784 mounted on ceramic substrate (250 mm² × 0.8 t)

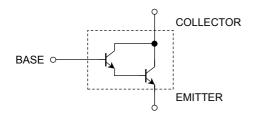


Weight: 0.05 g (typ.)

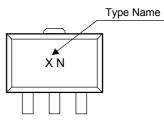
Electrical Characteristics (Ta = 25°C)

Charac	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Collector cut-off current		I _{CBO}	V _{CB} = 30 V, I _E = 0	—	—	10	μA
Emitter cut-off current		I _{EBO}	V _{EB} = 10 V, I _C = 0	_	_	10	μA
Collector-emitter breakdown voltage		V (BR) CEO	I _C = 10 mA, I _B = 0	30	_	_	V
DC current gain		h _{FE}	V _{CE} = 2 V, I _C = 150 mA	4000	_	-	-
Collector-emitter saturation voltage		V _{CE (sat)}	I _C = 1 A, I _B = 1 mA	_	_	1.5	V
Base-emitter saturation voltage		V _{BE (sat)}	I _C = 1 A, I _B = 1 mA	_	_	2.2	V
Switching time	Turn-on time	t _{on}		_	0.20	_	
	Storage time	t _{stg}		_	0.6	_	μs
	Fall time	t _f	$I_{B(1)} = I_{B(2)} = 1 \text{ mA}$ $V_{CC} = 15 \text{ V}$ DUTY CYCLE ≤ 1%	_	0.3	_	

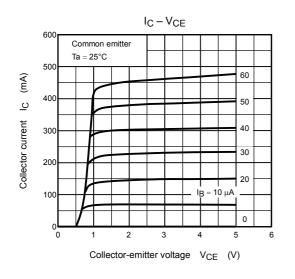
Equivalent Circuit

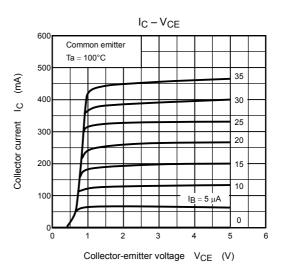


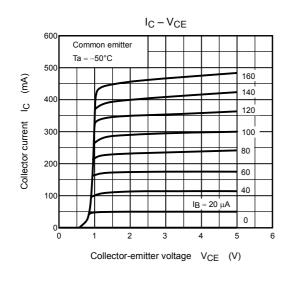
Marking

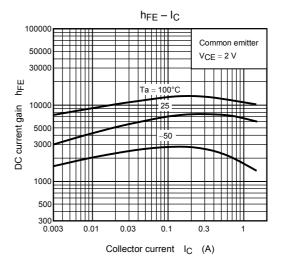


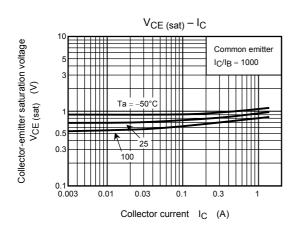
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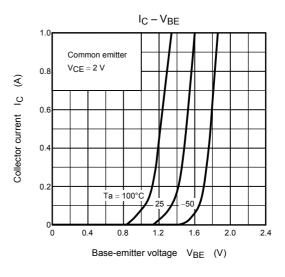




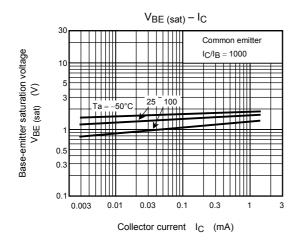


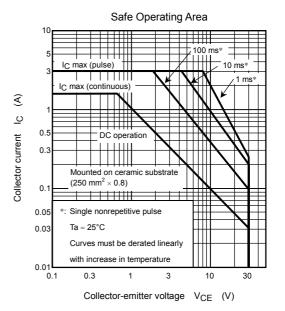


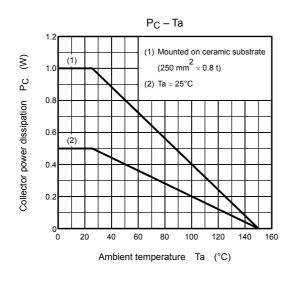




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